Normalized signature graph of analog circuits for fault classification using digital testing

Mohamed Hassan Elmahlawy

Abstract

https://www.sciencedirect.com/science/article/pii/S209044792400340X?via%3Dihub

Ain Shams Engineering Journal 2024, September

Future University In Egypt (http://www.fue.edu.eg)

Copyright É 2026 [Future University in Egypt]. All rights reserved.